

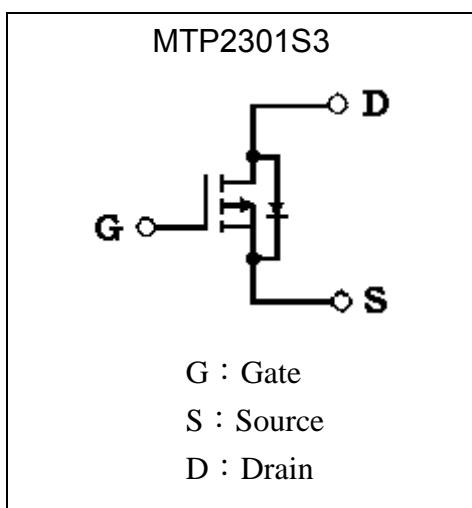
## 20V P-Channel Enhancement Mode MOSFET

BVDSS	-20V
ID@TA=25°C, VGS=-4.5V	-2.8A
RDS(on)(MAX)@VGS=-4.5V, ID=-2.8A	70mΩ (typ.)
RDS(on)(MAX)@VGS=-2.5V, ID=-2.0A	87mΩ (typ.)

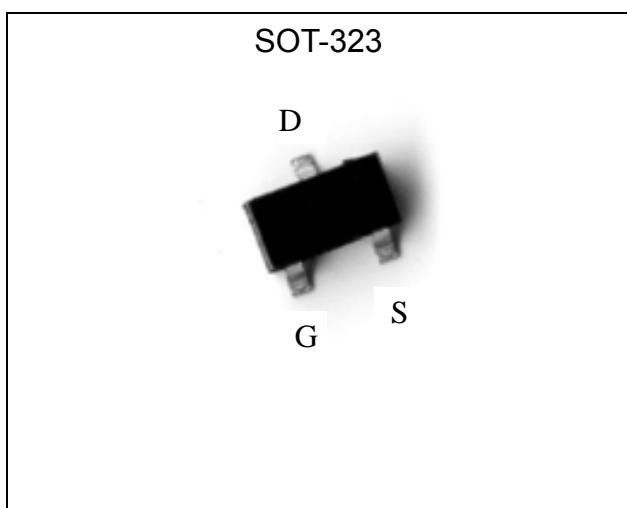
### Features

- Advanced trench process technology
- High density cell design for ultra low on resistance
- Excellent thermal and electrical capabilities
- Compact and low profile SOT-323 package
- Pb-free lead plating and halogen-free package

### Equivalent Circuit



### Outline



### Ordering Information

Device	Package	Shipping
MTP2301S3-0-T1-G <small>(Pb-free lead plating and halogen-free package)</small>	SOT-323	3000 pcs / Tape & Reel

Environment friendly grade : S for RoHS compliant products, G for RoHS compliant and green compound products

Packing spec, T1 : 3000 pcs / tape & reel, 7" reel

Product rank, zero for no rank products

Product name

**Absolute Maximum Ratings (Ta=25°C)**

Parameter		Symbol	Limits	Unit
Drain-Source Voltage		V <sub>DS</sub>	-20	V
Gate-Source Voltage		V <sub>GS</sub>	±12	
Continuous Drain Current @ Ta=25°C, V <sub>GS</sub> =-4.5V	ID		-2.8	A
Continuous Drain Current @ Ta=70°C, V <sub>GS</sub> =-4.5V			-1.6	
Pulsed Drain Current	IDM		-10	
Maximum Power Dissipation	Ta=25°C	P <sub>D</sub>	340 (Note)	mW
	Ta=70°C		218 (Note)	
Operating Junction and Storage Temperature Range		T <sub>j</sub> ; T <sub>stg</sub>	-55~+150	°C

**Thermal Performance**

Parameter	Symbol	Limit	Unit
Thermal Resistance, Junction-to-Ambient(PCB mounted)	R <sub>th,ja</sub>	367 (Note)	°C/W

Note : Device mounted on minimum copper pad.

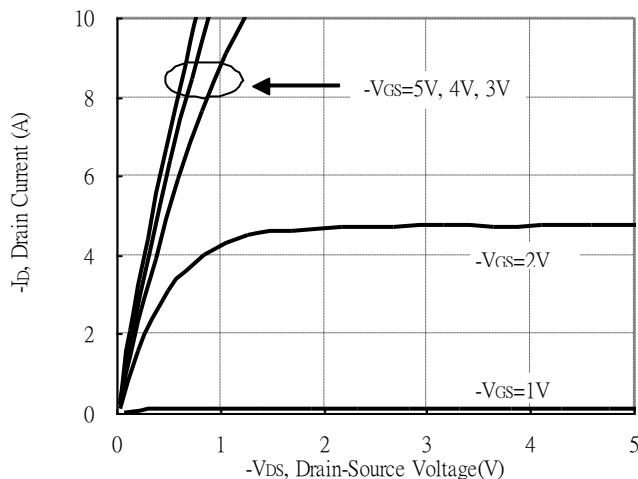
**Electrical Characteristics (Ta=25°C)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions	
<b>Static</b>						
BV <sub>DSS</sub>	-20	-	-	V	V <sub>GS</sub> =0V, ID=-250µA	
V <sub>GS(th)</sub>	-0.45	-	-1		V <sub>DS</sub> =V <sub>GS</sub> , ID=-250µA	
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±8V, V <sub>DS</sub> =0V	
I <sub>DSS</sub>	-	-	-1	µA	V <sub>DS</sub> =-16V, V <sub>GS</sub> =0V	
*R <sub>DSON</sub>	-	70	95	mΩ	ID=-2.8A, V <sub>GS</sub> =-4.5V	
	-	87	130		ID=-2.0A, V <sub>GS</sub> =-2.5V	
*G <sub>FS</sub>	-	4	-	S	V <sub>DS</sub> =-5V, ID=-2.8A	
<b>Dynamic</b>						
C <sub>iss</sub>	-	589	-	pF	V <sub>DS</sub> =-10V, V <sub>GS</sub> =0V, f=1MHz	
C <sub>oss</sub>	-	92	-			
C <sub>rss</sub>	-	68	-			
t <sub>d(ON)</sub>	-	9.2	20	ns	V <sub>DD</sub> =-10V, ID=-1A, V <sub>GS</sub> =-4.5V, R <sub>G</sub> =6Ω	
t <sub>r</sub>	-	7.3	60			
t <sub>d(OFF)</sub>	-	38	50			
t <sub>f</sub>	-	12	20			
Q <sub>g</sub>	-	4.4	-	nC	V <sub>DS</sub> =-10V, ID=-1.6A, V <sub>GS</sub> =-2.5V	
Q <sub>gs</sub>	-	0.5	-			
Q <sub>gd</sub>	-	1.5	-			
<b>Source-Drain Diode</b>						
I <sub>S</sub>	-	-	-1.6	A		
V <sub>SD</sub>	-	-0.86	-1.2	V	V <sub>GS</sub> =0V, I <sub>S</sub> =-1.6A	
t <sub>rr*</sub>	-	30	-	ns	I <sub>F</sub> =-3A, dI <sub>F</sub> /dt=100A/µs	
Q <sub>rr*</sub>	-	25	-	nC		

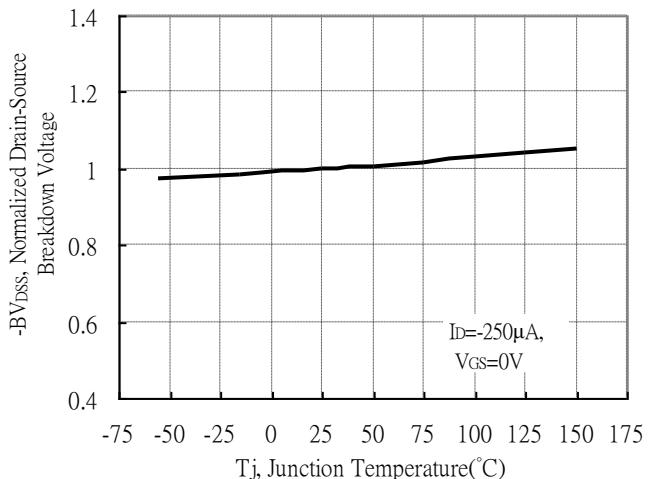
\*Pulse Test : Pulse Width ≤300µs, Duty Cycle≤2%

## Typical Characteristics

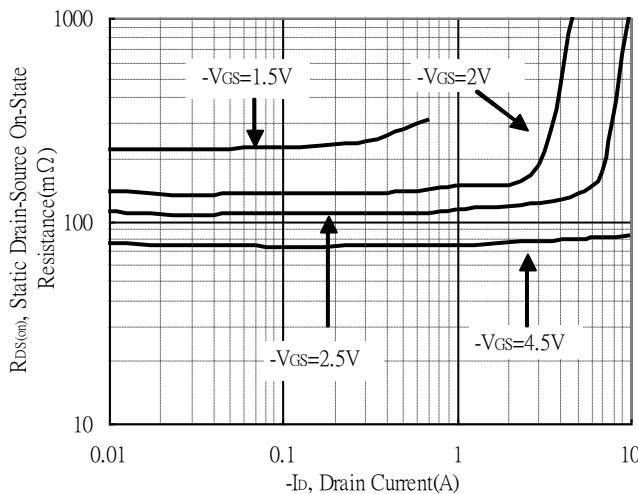
Typical Output Characteristics



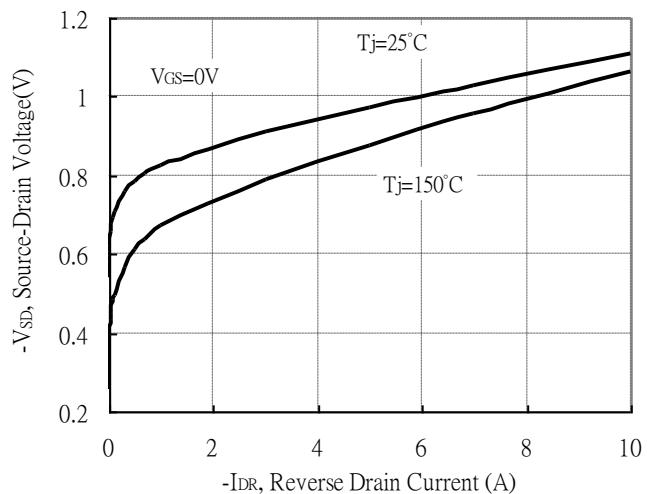
Breakdown Voltage vs Ambient Temperature



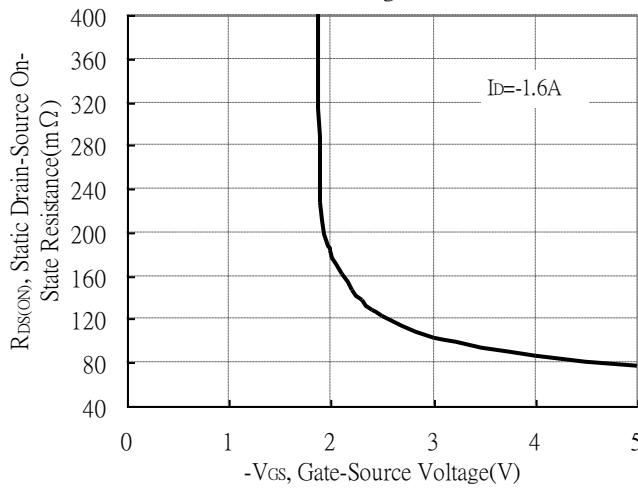
Static Drain-Source On-State resistance vs Drain Current



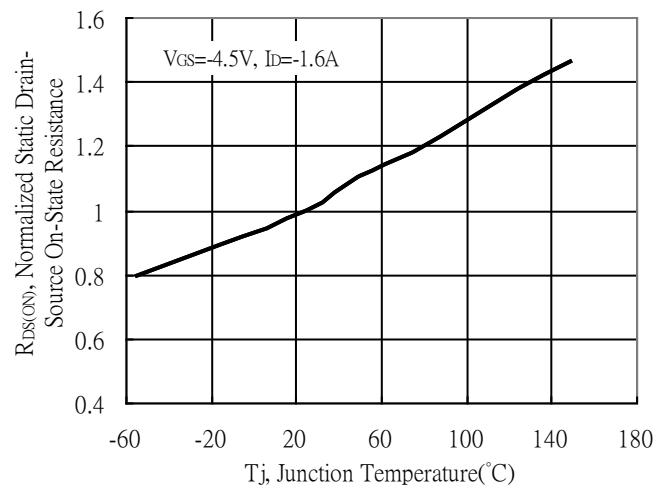
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

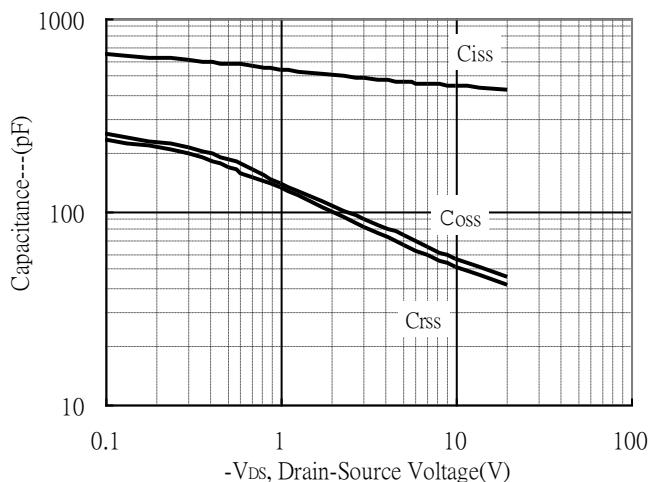


Drain-Source On-State Resistance vs Junction Temperature

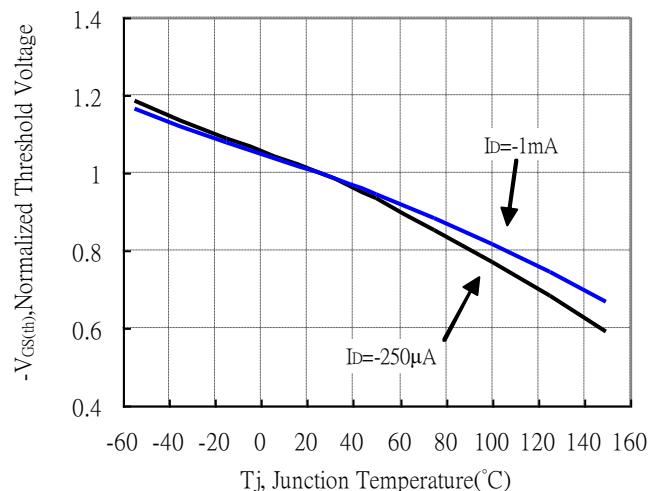


## Typical Characteristics(Cont.)

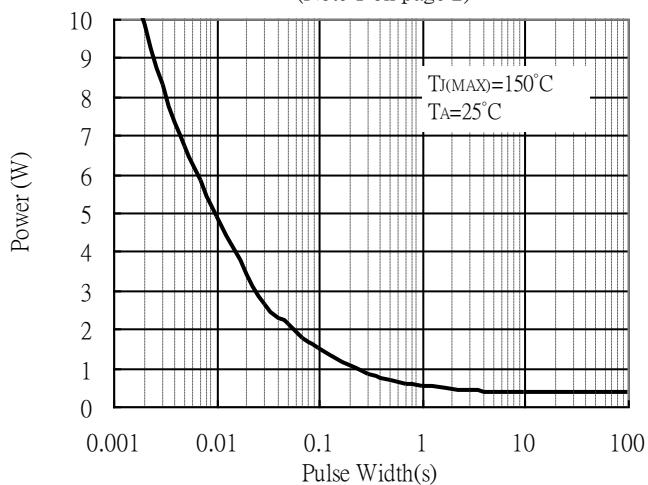
Capacitance vs Drain-to-Source Voltage



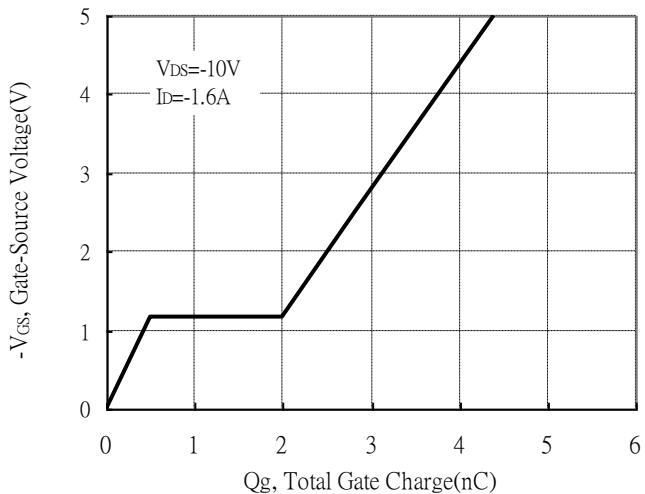
Threshold Voltage vs Junction Temperature



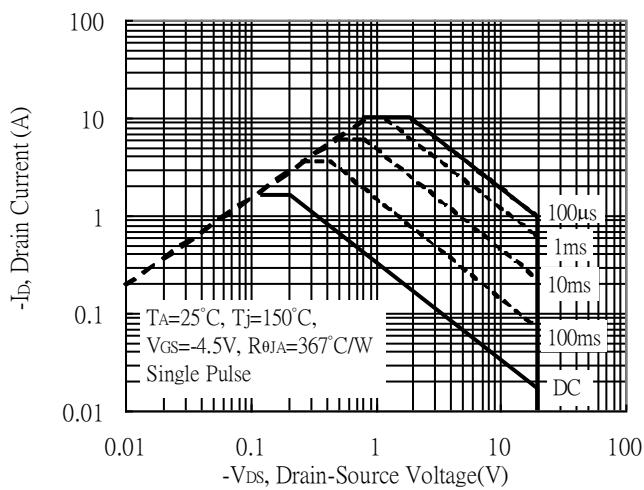
Single Pulse Power Rating, Junction to Ambient  
(Note 1 on page 2)



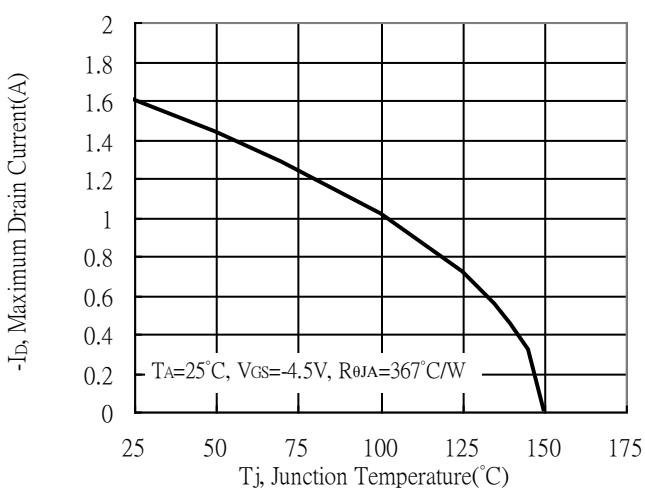
Gate Charge Characteristics



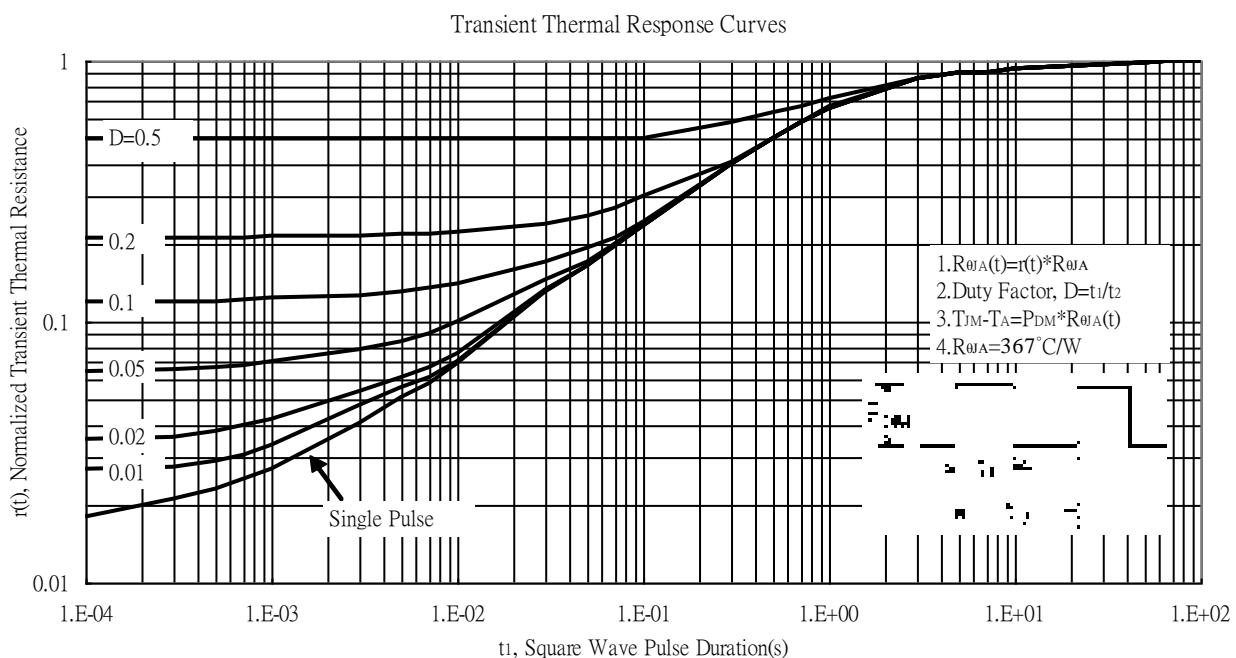
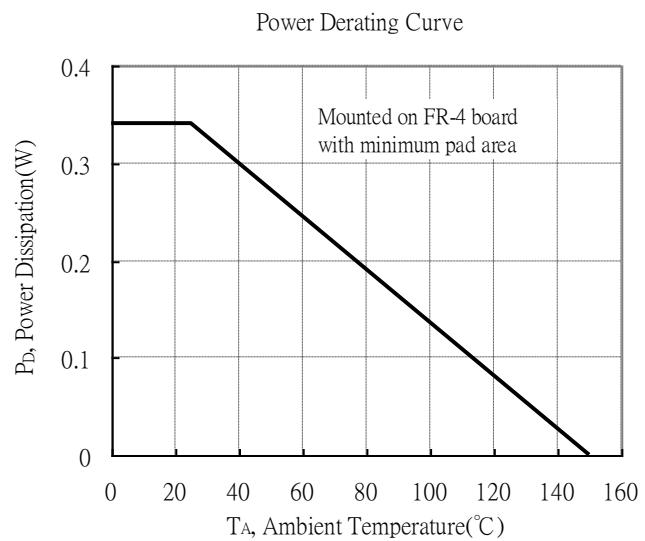
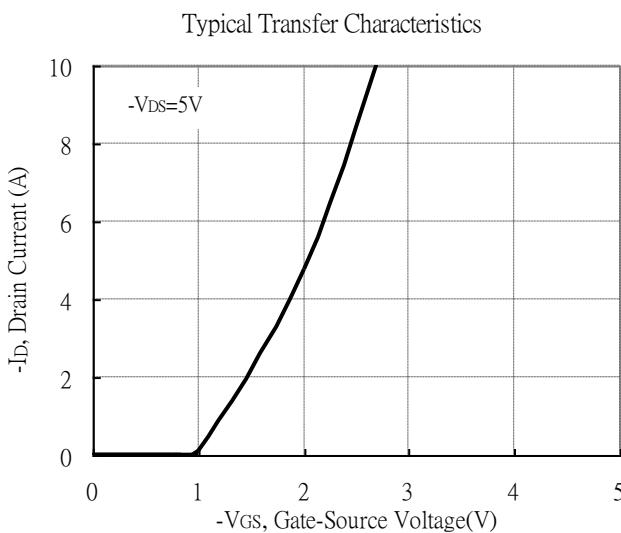
Maximum Safe Operating Area



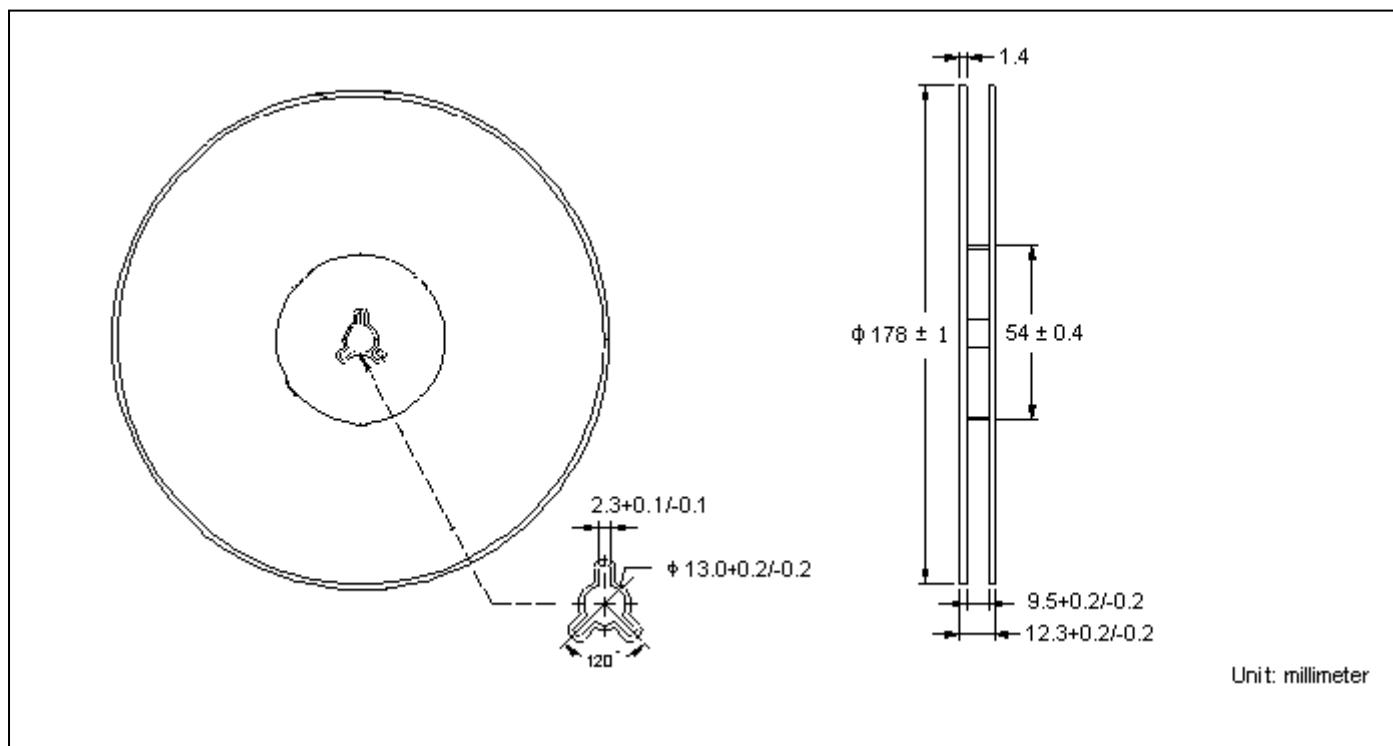
Maximum Drain Current vs Junction Temperature



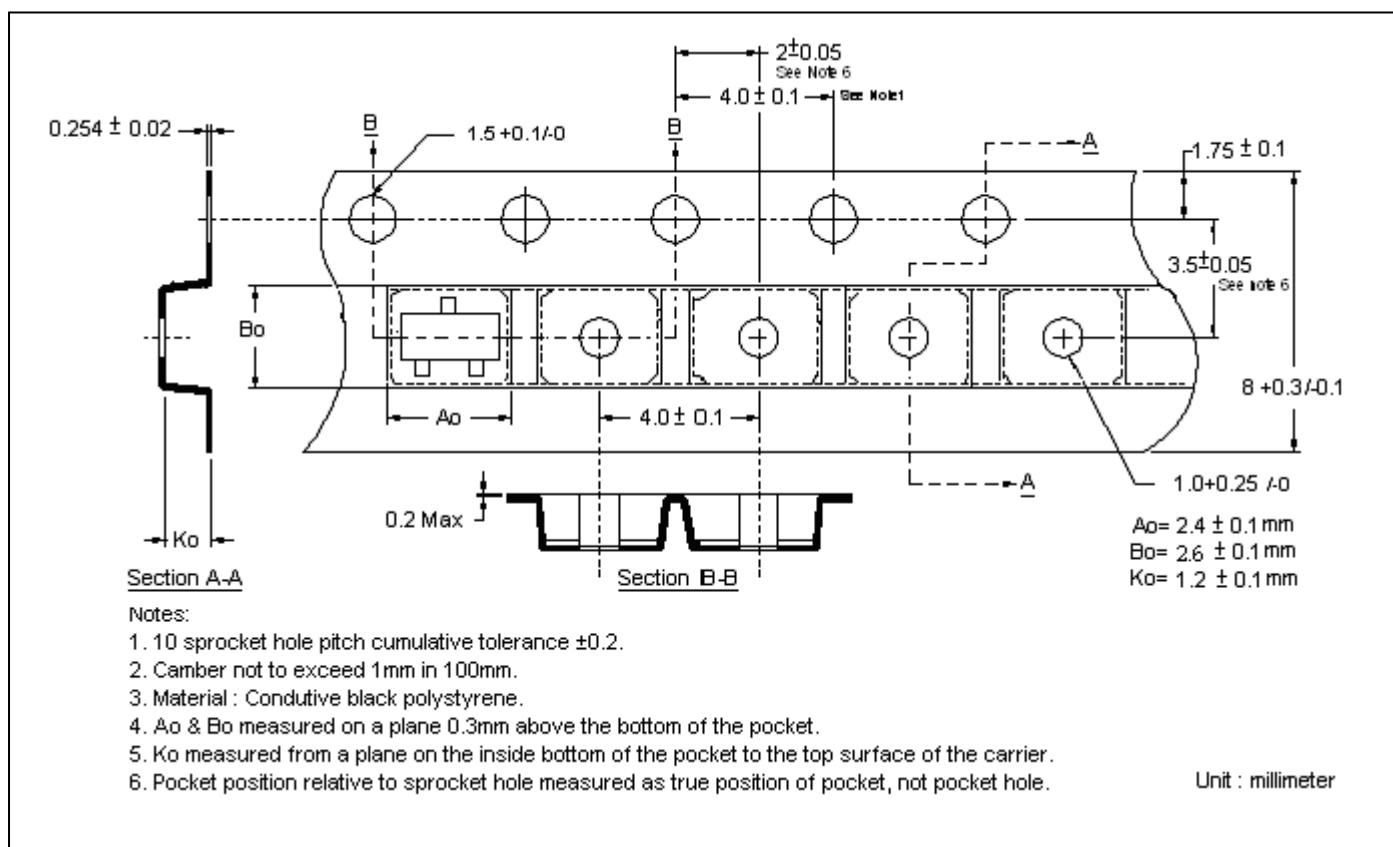
## Typical Characteristics(Cont.)



## Reel Dimension

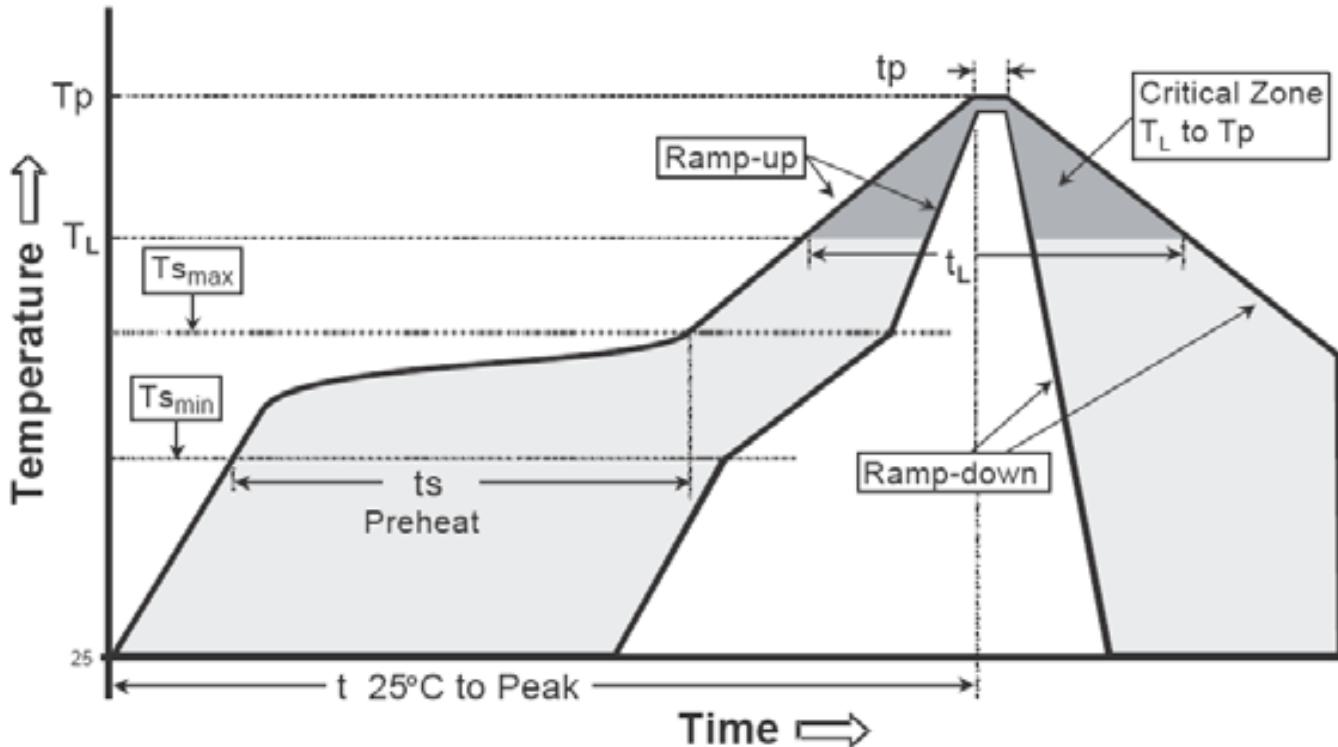


## Carrier Tape Dimension



**Recommended wave soldering condition**

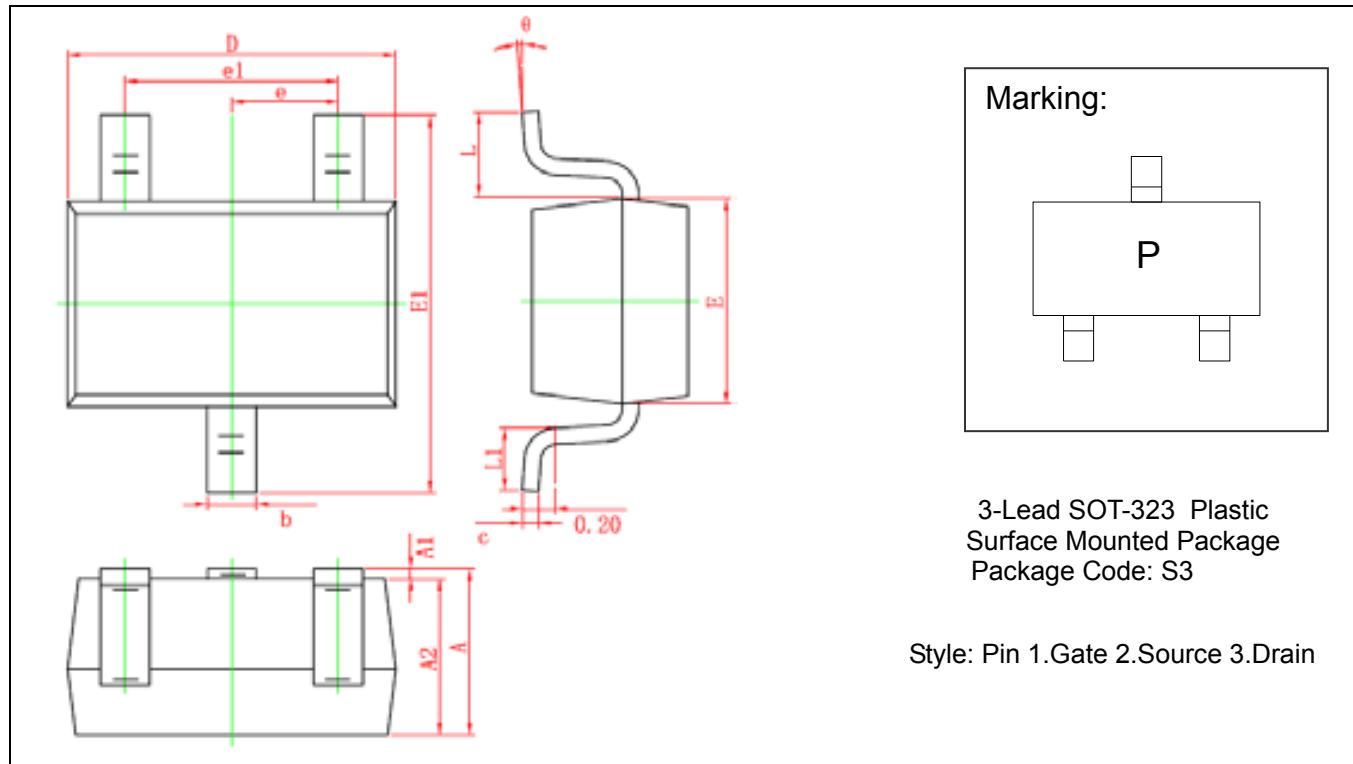
Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

**Recommended wave soldering condition**

Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate ( $T_{s\max}$ to $T_p$ )	3°C/second max.	3°C/second max.
Preheat -Temperature Min( $T_{s\min}$ ) -Temperature Max( $T_{s\max}$ ) -Time( $t_{s\min}$ to $t_{s\max}$ )	100°C 150°C 60-120 seconds	150°C 200°C 60-180 seconds
Time maintained above: -Temperature ( $T_L$ ) - Time ( $t_L$ )	183°C 60-150 seconds	217°C 60-150 seconds
Peak Temperature( $T_p$ )	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature( $t_p$ )	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

## SOT-323 Dimension



DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.900	1.100	0.035	0.043	E1	2.150	2.450	0.085	0.096
A1	0.000	0.100	0.000	0.004	e	0.650	TYP	0.026	TYP
A2	0.900	1.000	0.035	0.039	e1	1.200	1.400	0.047	0.055
b	0.200	0.400	0.008	0.016	L	0.525	REF	0.021	REF
c	0.080	0.150	0.003	0.006	L1	0.260	0.460	0.010	0.018
D	2.000	2.200	0.079	0.087	θ	0°	8°	0°	8°
E	1.150	1.350	0.045	0.053					

Notes: 1. Controlling dimension: millimeters.

2. Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.

### Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.